

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination OGINO ET AL.	
			Examiner HUY Q. PHAN	Art Unit 2617	Page 1 of 1

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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